

May–June 1999
Volume 104, Number 3

ISSN 1044-677X



Journal of Research of the

National Institute of Standards and Technology



United States Department of Commerce
Technology Administration
National Institute of Standards and Technology

Available online
<http://www.nist.gov/jres>

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- Distributed Computing and Information Services
- Software Diagnostics and Conformance Testing

¹ At Boulder, CO 80303.

² Some elements at Boulder, CO.

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Contents

Available online
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Articles

The NIST Length Scale Interferometer	John S. Beers and William B. Penzes	225
Vacuum Processing Technique for Development of Primary Standard Blackbodies	M. Navarro, S. S. Bruce, B. Carol Johnson, A. V. Murthy and R. D. Saunders	253
Small Angle Neutron Scattering by the Magnetic Microstructure of Nanocrystalline Ferromagnets Near Saturation	J. Weissmüller, R. D. McMichael, A. Michels, and R. D. Shull	261
Primary Phase Field of the Pb-doped 2223 High- T_c Superconductor in the (Bi, Pb)-Sr-Ca-Cu-O System	W. Wong-Ng, L. P. Cook, A. Kearsley, and W. Greenwood	271

Conference Reports

Electronic Commerce of Component Information Workshop	James A. St. Pierre, Curtis H. Parks, and Ronald Waxman	291
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News Briefs

GENERAL DEVELOPMENTS	299
Atoms Mimic Laser Light in First-Ever Matter Wave Mixing Experiment Get a Jump on the Bug With New NIST Kit Sprinkler Testing Without the High Cost, Mess . . . or the Flames	
Antenna Measurements Fortified by OATS New Primer for “Steam Tables” Hot Off the Presses Paper Highlights History, Importance of Impact Testing	300
Lost in Translation: \$1 Billion ATP to Hone Cutting Edge at Fall National Meeting NIST Models Benefit Industry, Society	301
Workshop to Focus on Parcel Shipping Scale Regulations Biometric Groups Merge, Unify Interface Development	302

NIST Conducts Interlaboratory Comparison for Magnetic Thin-Film Head Metrology Gas-Coupled Ultrasonics for Pipeline Inspection NIST Helps Industry to Improve Software Quality Industry and Research Community to Benefit From NIST Public Key Infrastructure (PKI) Reference Implementation	303
NIST Develops New Method for Flame Suppression Efficiency Screening Highly Directional Atom Laser Demonstrated Nonlinear Matter Wave Optics	304
New Results for Plasma Sprayed Coatings NIST Identifies Ceramic Resonator Alternative for Wireless Communications NIST Develops Absolute Magnetometer for Calibration of Magnetic Material Standards	305
NIST Develops New Techniques to Address Recession, Rotation Times, and High Coercivity Issues	306
NIST Develops Testing Software That Addresses \$500 Million Problem in Electronics Manufacturing Industry NIST's Vacuum-Gap Capacitor May Result in New Prototype Standard for Capacitance	307
Energetic Polyatomic Ion Bombardment for Surface Analysis Initial "Charters of Freedom" Encasement Delivered NIST and a Private Company Develop Laser-Based Step Gauge Product Data Management Interface Standard Revised	308
Autonomous Driving Demo Impresses U.S. and German Defense Agency Sponsors NIST Mathematician Collaborates on Computation of Three-Dimensional Dimer Constant Acoustic Resonator for Measuring Force NIST Workshop Identifies Needs for Heart Valve Research	309
Process and Construction Industries Expand Partnership With NIST Workshops Hosted on Telecommunication Synchronization First Roadmap Workshop for Environmental Scanning Electron Microscopy	310
New Methods to Improve Safety of Pressurized Gas Tanks NIST Works With Digital TV Environment Group to Develop Reference Implementation	311
NIST Researchers Document Speech Recognition Benchmark Tests NIST Will Lead Study on Danger of Fire Smoke Quality and Performance Excellence Star in Four-Video Set	312
Promising Strategy May Help Overcome Measurement Dilemma Researcher Investigates Reliability Problems with Flip-Chips Documents Tell How to Improve Cavity Measurement Accuracy	313
Digital Television (DTV) Comes to NIST NIST Software Helps Police Pick Vehicles First Measurement of Prototype Electrical CD Reference Feature Made Using Silicon Lattice as Ruler	314

New Procedure Solves Long-Standing Problem Associated With Making Multiport On-Wafer Scattering Parameter Measurements	315
NIST Researchers Collaborate With Microwave Manufacturer to Characterize Properties of New Composite Material	
<hr/>	
NIST Provides Noise-Temperature Measurement Service for Sources With 2.4 mm Coaxial Connectors	316
NIST Develops First Known Prototypes for On-Wafer Diode Noise Sources	
Battery Materials Investigated With Neutron Beams	
Manufacture and Certification of Electrodeposited Coating Thickness Standards	
<hr/>	
X-Ray Technique Offers Promise as Measurement for Electronic Structure in Crystalline Materials	317
Ferrite Standards Enter SRM Inventory	
<hr/>	
Provisional Patent Issued for Tool Tuning System	318
EXPRESS Web Server Released	
Successful Step Height Intercomparison between Calibrated Stylus and C-AFM	
Visualization of Vortices in Bose Einstein Condensates	
<hr/>	
Flame Retardant Project Reaches Successful Conclusion	319
Workshop Held on Electrical Safety Systems for the Americas	
Sino-U.S. Workshop on Standards and Conformity Assessment Held in Beijing, China	
<hr/>	
NIST Co-Sponsors Workshop on Low-Level and Environmental Radionuclide Mass Spectrometry and Atom Counting	320
NIST to Host the International Intercomparison of NIR Spectral Responsivity and Reduced Uncertainties in the NIST NIR Spectral Response Scale	
<hr/>	
STANDARD REFERENCE MATERIALS	321
Spare the Rod, Spoil the Accuracy for Fiber Measurements	
<hr/>	
STANDARD REFERENCE DATA	321
New NIST Atomic Spectra Database Created	
